

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/721,075	TANAKA, KOICHIRO
Examiner	Art Unit	
	M. Alexandra Elve	3742

SEARCHED

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
219	121.76	11/21/2010	MAE
219	121.78	11/21/2010	MAE
219	121.81	11/21/2010	MAE

SEARCH NOTES (INCLUDING SEARCH STRATEGY)